

Notice of References Cited	Application/Control No. 09/995,328	Applicant(s)/Patent Under Reexamination BERTRAM ET AL.	
	Examiner Paul A. Zucker	Art Unit 1621	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,473,079	12-1995	Heywang et al	--
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
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FOREIGN PATENT DOCUMENTS

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N					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Wang et al American Chemical Society, 220 th National Meeting, Abstract POLY-416, 2000.
V	
W	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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